

Vishay Siliconix

## N-Channel 8 V (D-S) MOSFET

# MICRO FOOT® 1 x 1 Bump Side View **Backside View**

Marking code: xxxx = 8466

PRODUCT SUMMARY	
V <sub>DS</sub> (V)	8
$R_{DS(on)}$ max. ( $\Omega$ ) at $V_{GS} = 4.5 \text{ V}$	0.043
$R_{DS(on)}$ max. ( $\Omega$ ) at $V_{GS} = 2.5 \text{ V}$	0.046
$R_{DS(on)}$ max. ( $\Omega$ ) at $V_{GS} = 1.5 \text{ V}$	0.060
$R_{DS(on)}$ max. ( $\Omega$ ) at $V_{GS} = 1.2 \text{ V}$	0.090
Q <sub>g</sub> typ. (nC)	6.8
I <sub>D</sub> (A) a, e	5.4
Configuration	Single

#### **FEATURES**

- TrenchFET® power MOSFET
- Typical ESD protection 3000 V HBM
- Ultra small 1 mm x 1 mm maximum outline
- Ultra thin 0.548 mm maximum height
- Material categorization: for definitions of compliance please see www.vishay.com/doc?99912

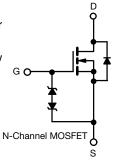


RoHS COMPLIANT

HALOGEN FREE

#### **APPLICATIONS**

- · Low on-resistance load switch for portable devices
  - Low power consumption, low voltage drop
  - Increased battery life
  - Space savings on PCB



ORDERING INFORMATION					
Package	MICRO FOOT				
Lead (Pb)-free and halogen-free Si8466EDB-T2-E1					
ABSOLUTE MAXIMUM RATINGS (T <sub>A</sub> = 25 °C, unless otherwise noted)					

<b>ABSOLUTE MAXIMUM RATINGS</b> (T <sub>A</sub> = 25 °C, unless otherwise noted)						
PARAMETER		SYMBOL	LIMIT	UNIT		
Drain-source voltage		$V_{DS}$	8	V		
Gate-source voltage		$V_{GS}$	± 5	\ \ \		
	T <sub>A</sub> = 25 °C		5.4 <sup>a</sup>			
Continuous drain surrent (T. 150 °C)	T <sub>A</sub> = 70 °C		4.4 <sup>a</sup>			
Continuous drain current (T <sub>J</sub> = 150 °C)	T <sub>A</sub> = 25 °C	I <sub>D</sub>	3.6 b			
	T <sub>A</sub> = 70 °C	†	2.9 b	Α		
Pulsed drain current (t = 300 μs)		I <sub>DM</sub>	20			
Continuous source drain diada surrent	T <sub>C</sub> = 25 °C	I <sub>S</sub>	1.5 <sup>a</sup>			
Continuous source-drain diode current	T <sub>A</sub> = 25 °C		0.65 b			
	T <sub>A</sub> = 25 °C		1.8 <sup>a</sup>			
Maximum navar dissination	T <sub>A</sub> = 70 °C	р	1.1 <sup>a</sup>	W		
Maximum power dissipation	T <sub>A</sub> = 25 °C	P <sub>D</sub>	0.78 <sup>b</sup>	] vv		
	T <sub>A</sub> = 70 °C		0.5 <sup>b</sup>			
Operating junction and storage temperature range		T <sub>J</sub> , T <sub>stg</sub>	-55 to +150			
Package reflow conditions <sup>c</sup>	VPR		260	°C		
	IR/convection		260			

THERMAL RESISTANCE RATINGS					
PARAMETER		SYMBOL	TYPICAL	MAXIMUM	UNIT
Maximum junction-to-ambient f, g	t = 10 s	D+	55	70	°C/W
Maximum junction-to-ambient h, i	t = 10 s	Rt <sub>hJA</sub>	125	160	C/VV

- a. Surface mounted on 1" x 1" FR4 board with full copper, t = 10 s
  b. Surface mounted on 1" x 1" FR4 board with minimum copper, t = 10 s
  c. Refer to IPC/JEDEC® (J-STD-020), no manual or hand soldering

- d. In this document, any reference to case represents the body of the MICRO FOOT device and foot is the bump e. Based on  $T_A = 25~^{\circ}\text{C}$
- Surface mounted on 1" x 1" FR4 board with full copper Maximum under steady state conditions is 100 °C/W Surface mounted on 1" x 1" FR4 board with minimum copper



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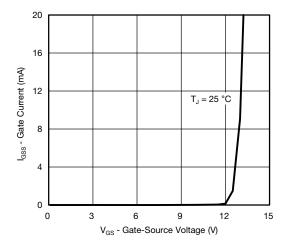
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Static							
Drain-source breakdown voltage	V <sub>DS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250 μA	8	-	-	V	
V <sub>DS</sub> temperature coefficient	$\Delta V_{DS}/T_{J}$	J 050 A	-	3.5	-	mV/°C	
V <sub>GS(th)</sub> temperature coefficient	$\Delta V_{GS(th)}/T_J$	$I_D = 250 \mu\text{A}$	-	-3	-	IIIV/ C	
Gate-source threshold voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_D = 250 \mu A$	0.35	-	0.7	V	
Gate-source leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 5 \text{ V}$	-	-	± 3	μΑ	
Zoro gata valtaga drain aurrent	,	V <sub>DS</sub> = 8 V, V <sub>GS</sub> = 0 V	-	-	1	μΑ	
Zero gate voltage drain current	I <sub>DSS</sub>	V <sub>DS</sub> = 8 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 70 °C	-	-	10		
On-state drain current a	I <sub>D(on)</sub>	$V_{DS} \ge 5 \text{ V}, V_{GS} = 4.5 \text{ V}$	10	-	-	Α	
		V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 2 A	-	0.035	0.043		
Drain aguras en eteta registance a		V <sub>GS</sub> = 2.5 V, I <sub>D</sub> = 1 A	-	0.037	0.046	Ω	
Drain-source on-state resistance a	R <sub>DS(on)</sub>	V <sub>GS</sub> = 1.5 V, I <sub>D</sub> = 1 A	-	0.045	0.060		
		V <sub>GS</sub> = 1.2 V, I <sub>D</sub> = 0.5 A	-	0.055	0.090		
Forward transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = 4 V, I <sub>D</sub> = 2 A	-	30	-	S	
Dynamic <sup>b</sup>			•				
Input capacitance	C <sub>iss</sub>		-	710	-	pF	
Output capacitance	C <sub>oss</sub>	$V_{DS} = 4 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	-	270	-		
Reverse transfer capacitance	C <sub>rss</sub>		-	192	-		
Total gate charge	Qg		-	8.5	13		
Gate-source charge	Q <sub>gs</sub>	$V_{DS} = 4 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 2 \text{ A}$	-	0.9	-	nC	
Gate-drain charge	$Q_{gd}$		-	1.6	-		
Gate resistance	R <sub>g</sub>	V <sub>GS</sub> = 0.1 V, f = 1 MHz	-	6	-	Ω	
Turn-on delay time	t <sub>d(on)</sub>		-	10	20		
Rise time	t <sub>r</sub>	$V_{DD} = 4 \text{ V}, R_1 = 2 \Omega,$	-	15	30		
Turn-off delay time	t <sub>d(off)</sub>	$I_D \cong 2 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$	-	40	80	ns	
Fall time	t <sub>f</sub>		-	10	20	1	
<b>Drain-Source Body Diode Character</b>	istics						
Continuous source-drain diode current	Is	T <sub>A</sub> = 25 °C	-	-	1.5	^	
Pulse diode forward current	I <sub>SM</sub>		-	-	20	A	
Body diode voltage	V <sub>SD</sub>	I <sub>S</sub> = 1.5 A, V <sub>GS</sub> = 0 V	-	0.7	1.2	V	
Body diode reverse recovery time	t <sub>rr</sub>		-	30	60	ns	
Body diode reverse recovery charge	Q <sub>rr</sub>	$I_F = 2 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s},$	-	7	15	nC	
Reverse recovery fall time	t <sub>a</sub>	$T_J = 25  ^{\circ}C$	-	15	-		
Reverse recovery rise time	t <sub>b</sub>		_	15	_	ns	

#### Notes

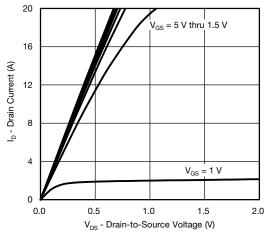
- a. Pulse test; pulse width  $\leq 300~\mu s,$  duty cycle  $\leq 2~\%$
- b. Guaranteed by design, not subject to production testing

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

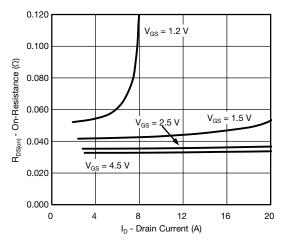




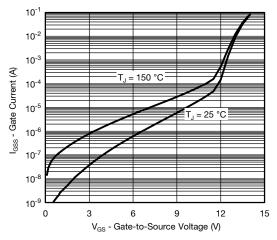
#### **Output Characteristics**



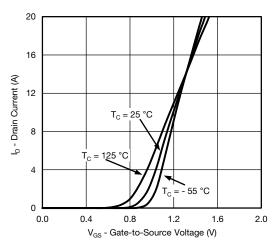
**Output Characteristics** 



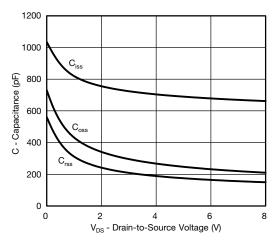
On-Resistance vs. Drain Current and Gate Voltage



On-Resistance vs. Drain Current and Gate Voltage

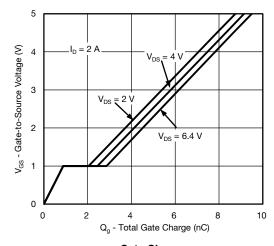


Transfer Characteristics

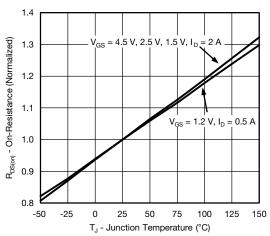


Capacitance

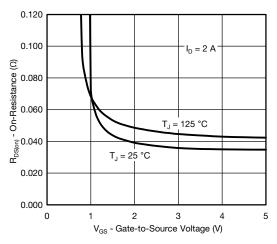




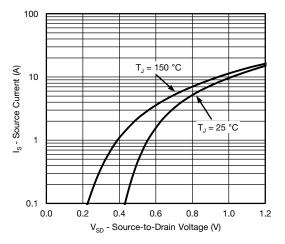
#### **Gate Charge**



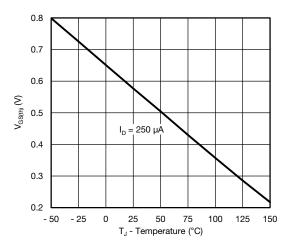
On-Resistance vs. Junction Temperature



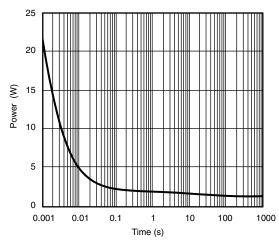
On-Resistance vs. Gate-to-Source Voltage



Source-Drain Diode Forward Voltage

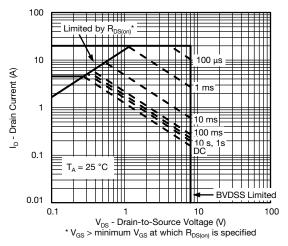


Threshold Voltage

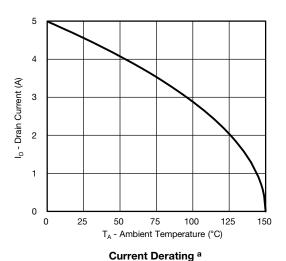


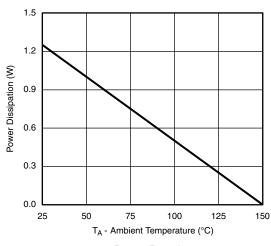
Single Pulse Power, Junction-to-Ambient





Safe Operating Area, Junction-to-Ambient



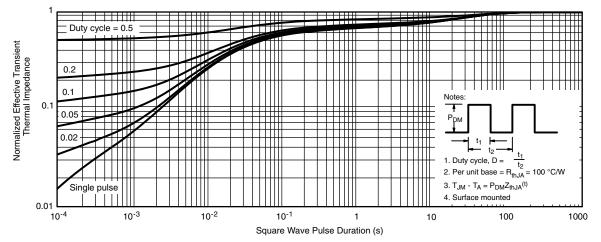


#### **Power Derating**

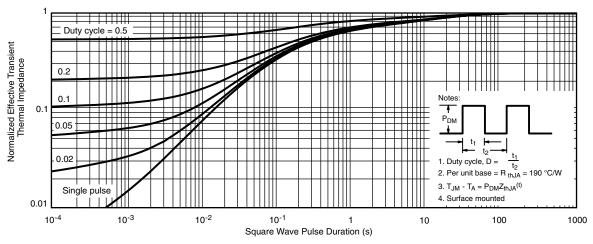
#### Notes

- When mounted on 1" x 1" FR4 with full copper
- a. The power dissipation P<sub>D</sub> is based on T<sub>J</sub> max. = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit





Normalized Thermal Transient Impedance, Junction-to-Ambient (1" x 1" FR4 Board with Full Copper)



Normalized Thermal Transient Impedance, Junction-to-Ambient (1" x 1" FR4 Board with Minimum Copper)

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package / tape drawings, part marking, and reliability data, see <a href="https://www.vishay.com/ppg?63683">www.vishay.com/ppg?63683</a>.

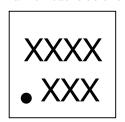


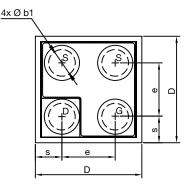
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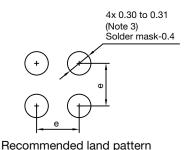
Vishay Siliconix

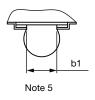
## MICRO FOOT®: 4-Bumps (1 mm x 1 mm, 0.5 mm Pitch, 0.286 mm Bump Height)

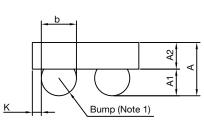
Mark on backside of die











#### Notes

- 1. Bumps are 95.5/3.8/0.7 Sn/Ag/Cu.
- 2. Backside surface is coated with a Ti/Ni/Ag layer.
- 3. Non-solder mask defined copper landing pad.
- 4. Laser mark on the backside surface of die.
- 5. "b1" is the diameter of the solderable substrate surface, defined by an opening in the solder resist layer solder mask defined.
- 6. is the location of pin 1

DIM.	MILLIMETERS			INCHES			
Dilvi.	MIN.	NOM.	MAX.	MIN.	NOM.	MAX.	
Α	0.458	0.504	0.550	0.0180	0.0198	0.0217	
A1	0.214	0.250	0.286	0.0084	0.0098	0.0113	
A2	0.244	0.254	0.264	0.0096	0.0100	0.0104	
b	0.297	0.330	0.363	0.0117	0.0130	0.0143	
b1	0.250				0.0098		
е		0.500			0.0197		
S	0.210	0.230	0.250	0.0083	0.0091	0.0096	
D	0.920	0.960	1.000	0.0362	0.0378	0.0394	
K	0.029	0.065	0.102	0.0011	0.0026	0.0040	

#### Note

• Use millimeters as the primary measurement.

ECN: T15-0176-Rev. A, 27-Apr-15

DWG: 6039

Revision: 27-Apr-15 1 Document Number: 69370



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Vishay

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